

APPENDIX B: ADT SAR MEASUREMENT SYSTEM



APPENDIX C: PHOTOGRAPHS OF SYSTEM VALIDATION





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 Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **ADT (Auden)**

Certificate No: **D2450V2-737_Mar05**

CALIBRATION CERTIFICATE

Object **D2450V2 - SN: 737**

Calibration procedure(s) **QA CAL-05.v6**
Calibration procedure for dipole validation kits

Calibration date: **March 16, 2005**

Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
 The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^\circ\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Power meter EPM E442	GB37480704	12-Oct-04 (METAS, No. 251-00412)	Oct-05
Power sensor HP 8481A	US37292783	12-Oct-04 (METAS, No. 251-00412)	Oct-05
Reference 20 dB Attenuator	SN: 5086 (20g)	10-Aug-04 (METAS, No 251-00402)	Aug-05
Reference 10 dB Attenuator	SN: 5047.2 (10r)	10-Aug-04 (METAS, No 251-00402)	Aug-05
Reference Probe ES3DV2	SN 3025	29-Oct-04 (SPEAG, No. ES3-3025_Oct04)	Oct-05
DAE4	SN 601	07-Jan-05 (SPEAG, No. DAE4-601_Jan05)	Jan-06
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power sensor HP 8481A	MY41092317	18-Oct-02 (SPEAG, in house check Oct-03)	In house check: Oct-05
RF generator R&S SML-03	100698	27-Mar-02 (SPEAG, in house check Dec-03)	In house check: Dec-05
Network Analyzer HP 8753E	US37390585 S4206	18-Oct-01 (SPEAG, in house check Nov-04)	In house check: Nov-05

	Name	Function	Signature
Calibrated by:	Judith Müller	Laboratory Technician	

Approved by:	Katja Pokovic	Technical Manager
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Issued: March 21, 2005

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Glossary:

TSL	tissue simulating liquid
ConvF	sensitivity in TSL / NORM x,y,z
N/A	not applicable or not measured

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) CENELEC EN 50361, "Basic standard for the measurement of Specific Absorption Rate related to human exposure to electromagnetic fields from mobile phones (300 MHz - 3 GHz), July 2001
- c) Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

- d) DASY4 System Handbook

Methods Applied and Interpretation of Parameters:

- *Measurement Conditions:* Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- *Antenna Parameters with TSL:* The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- *Feed Point Impedance and Return Loss:* These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- *Electrical Delay:* One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- *SAR measured:* SAR measured at the stated antenna input power.
- *SAR normalized:* SAR as measured, normalized to an input power of 1 W at the antenna connector.
- *SAR for nominal TSL parameters:* The measured TSL parameters are used to calculate the nominal SAR result.

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY4	V4.5
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V5.0	
Distance Dipole Center - TSL	10 mm	with Spacer
Area Scan resolution	dx, dy = 15 mm	
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	2450 MHz $\pm$ 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	39.2	1.80 mho/m
Measured Head TSL parameters	(22.0 $\pm$ 0.2) °C	39.9 $\pm$ 6 %	1.78 mho/m $\pm$ 6 %
Head TSL temperature during test	(21.5 $\pm$ 0.2) °C	---	---

SAR result with Head TSL

SAR averaged over 1 cm³ (1 g) of Head TSL	condition	
SAR measured	250 mW input power	13.7 mW / g
SAR normalized	normalized to 1W	54.8 mW / g
SAR for nominal Head TSL parameters ¹	normalized to 1W	55.5 mW / g $\pm$ 17.0 % (k=2)

SAR averaged over 10 cm³ (10 g) of Head TSL	condition	
SAR measured	250 mW input power	6.36 mW / g
SAR normalized	normalized to 1W	25.4 mW / g
SAR for nominal Head TSL parameters ¹	normalized to 1W	25.8 mW / g $\pm$ 16.5 % (k=2)

2

¹ Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

Body TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	52.7	1.95 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	52.3 ± 6 %	2.01 mho/m ± 6 %
Body TSL temperature during test	(22.0 ± 0.2) °C	---	---

SAR result with Body TSL

SAR averaged over 1 cm³ (1 g) of Body TSL	condition	
SAR measured	250 mW input power	13.4 mW / g
SAR normalized	normalized to 1W	53.6 mW / g
SAR for nominal Body TSL parameters ²	normalized to 1W	52.5 mW / g ± 17.0 % (k=2)

SAR averaged over 10 cm³ (10 g) of Body TSL	condition	
SAR measured	250 mW input power	6.18 mW / g
SAR normalized	normalized to 1W	24.7 mW / g
SAR for nominal Body TSL parameters ²	normalized to 1W	24.2 mW / g ± 16.5 % (k=2)

² Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	$52.4 \Omega + 5.6 j\Omega$
Return Loss	- 24.4 dB

Antenna Parameters with Body TSL

Impedance, transformed to feed point	$48.4 \Omega + 5.9 j\Omega$
Return Loss	- 24.2 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.161 ns
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After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	August 26, 2003

DASY4 Validation Report for Head TSL

Date/Time: 14.03.2005 16:57:15

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 2450 MHz; Type: D2450V2; Serial: D2450V2 - SN737

Communication System: CW-2450; Frequency: 2450 MHz; Duty Cycle: 1:1

Medium: HSL U10 BB;

Medium parameters used: $f = 2450$ MHz; $\sigma = 1.78$ mho/m; $\epsilon_r = 39.9$; $\rho = 1000$ kg/m³

Phantom section: Flat Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ES3DV2 - SN3025; ConvF(4.4, 4.4, 4.4); Calibrated: 29.10.2004
- Sensor-Surface: 4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 22.07.2004
- Phantom: Flat Phantom 5.0; Type: QD000P50AA; Serial: 1001;
- Measurement SW: DASY4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 146

Pin = 250 mW; d = 10 mm/Area Scan (81x81x1): Measurement grid: dx=15mm, dy=15mm

Maximum value of SAR (interpolated) = 15.9 mW/g

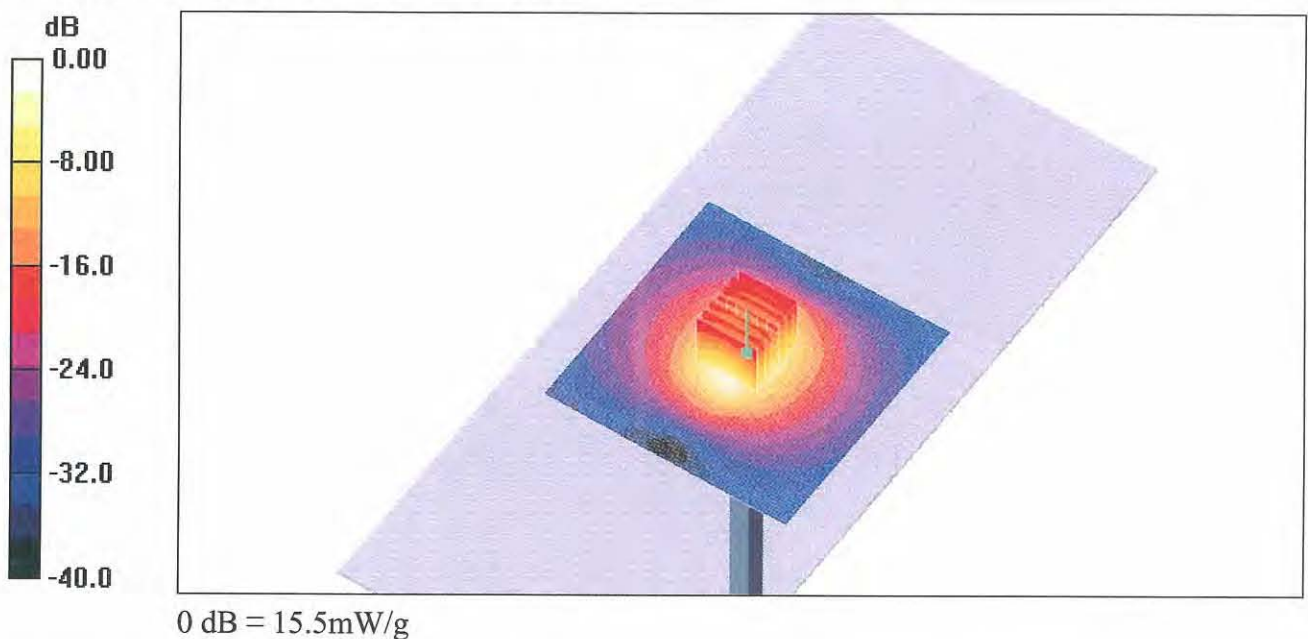
Pin = 250 mW; d = 10 mm/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 92.2 V/m; Power Drift = 0.090 dB

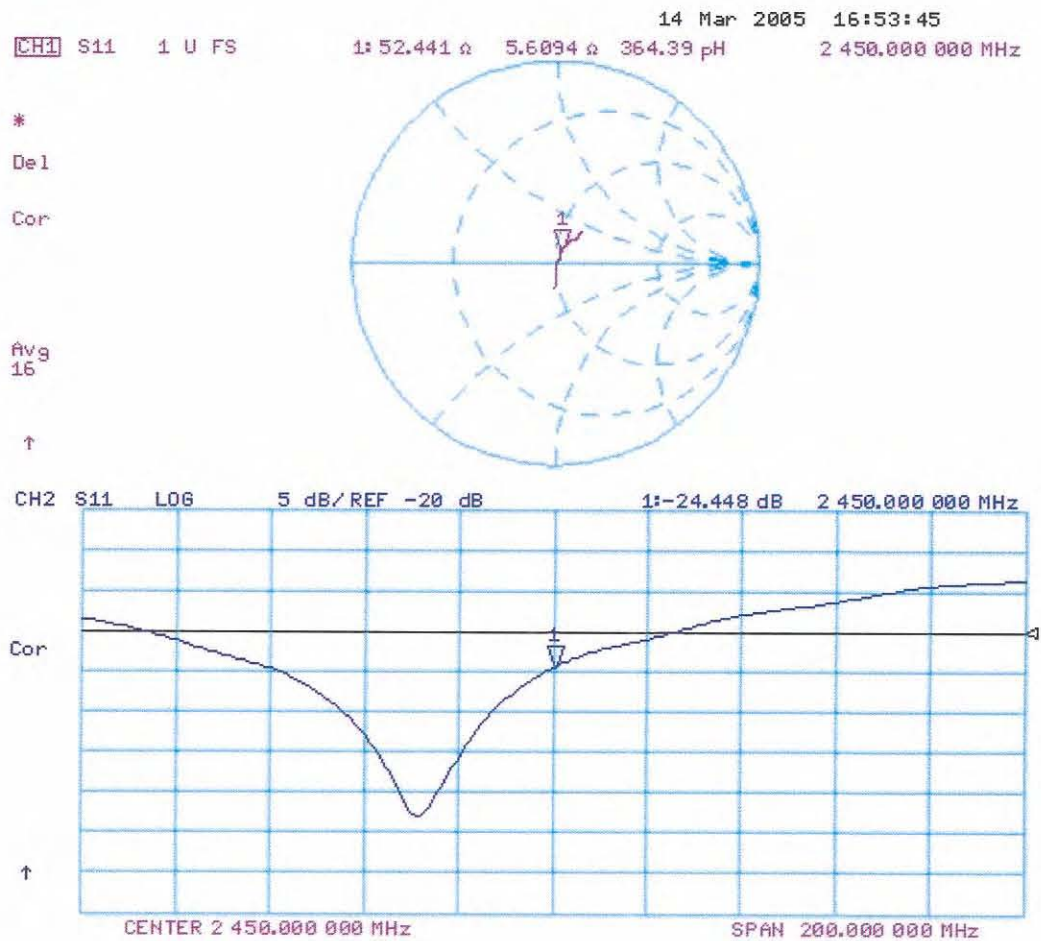
Peak SAR (extrapolated) = 28.0 W/kg

SAR(1 g) = 13.7 mW/g; SAR(10 g) = 6.36 mW/g

Maximum value of SAR (measured) = 15.5 mW/g



Impedance Measurement Plot for Head TSL



DASY4 Validation Report for Body TSL

Date/Time: 16.03.2005 10:09:20

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 2450 MHz; Type: D2450V2; Serial: D2450V2 - SN737

Communication System: CW-2450; Frequency: 2450 MHz; Duty Cycle: 1:1

Medium: M2450;

Medium parameters used: $f = 2450$ MHz; $\sigma = 2.01$ mho/m; $\epsilon_r = 52.3$; $\rho = 1000$ kg/m³

Phantom section: Flat Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ES3DV2 - SN3025; ConvF(4.13, 4.13, 4.13); Calibrated: 29.10.2004
- Sensor-Surface: 4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 22.07.2004
- Phantom: Flat Phantom 5.0; Type: QD000P50AA; Serial: 1001;
- Measurement SW: DASY4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 146

Pin = 250 mW; d = 10 mm/Area Scan (81x81x1): Measurement grid: dx=15mm, dy=15mm

Maximum value of SAR (interpolated) = 15.6 mW/g

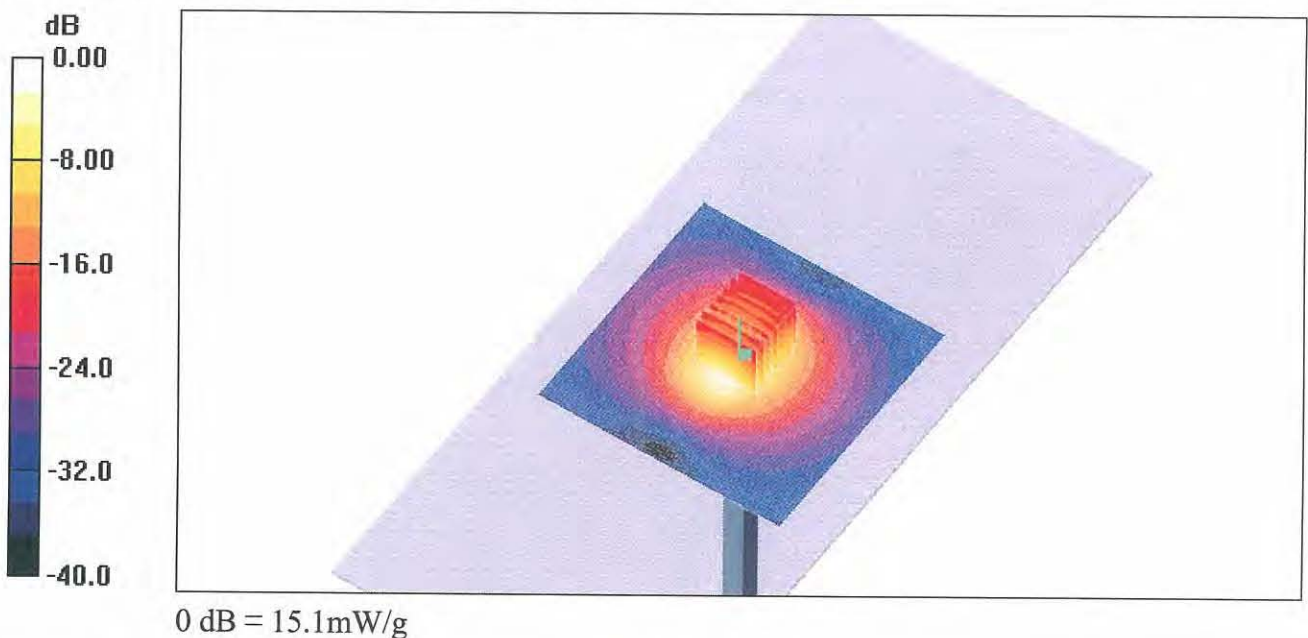
Pin = 250 mW; d = 10 mm/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 85.5 V/m; Power Drift = 0.079 dB

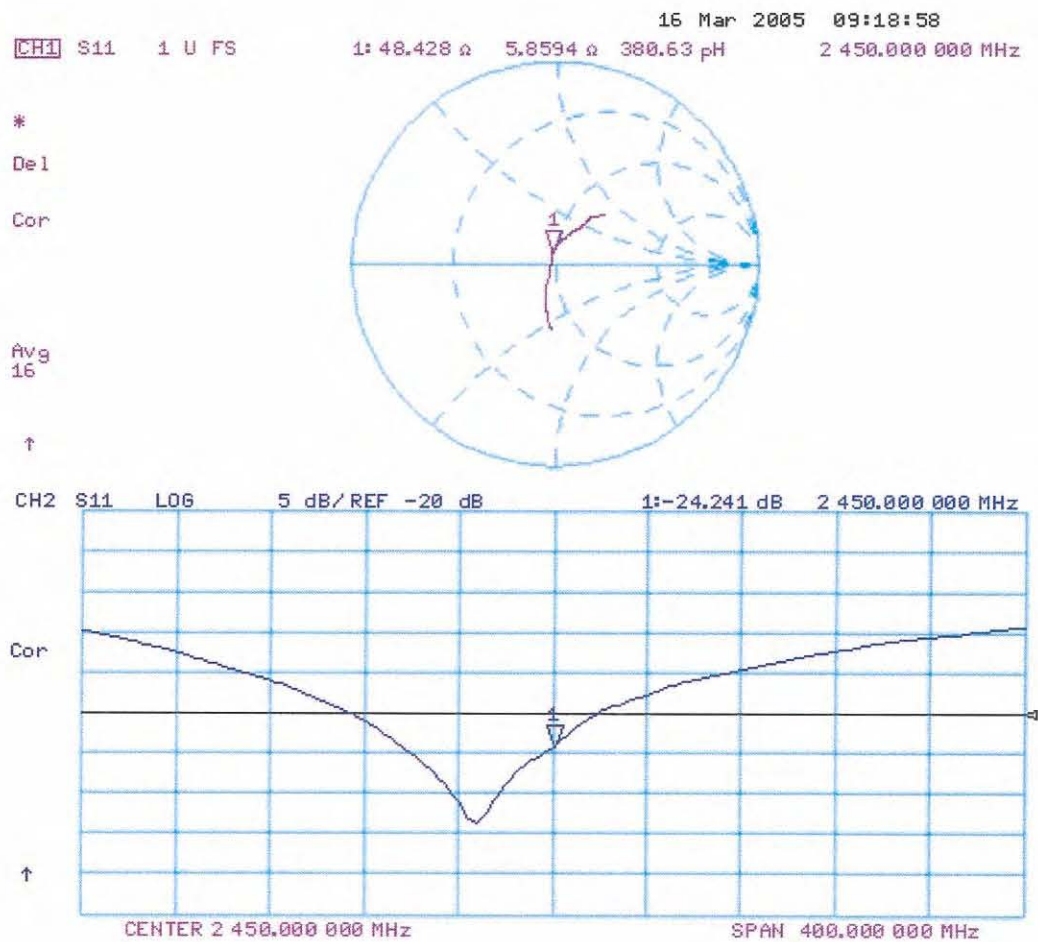
Peak SAR (extrapolated) = 27.3 W/kg

SAR(1 g) = 13.4 mW/g; SAR(10 g) = 6.18 mW/g

Maximum value of SAR (measured) = 15.1 mW/g



Impedance Measurement Plot for Body TSL





D2: DOSIMETRIC E-FIELD PROBE SN: 1753

Calibration Laboratory of
Schmid & Partner
Engineering AG
 Zeughausstrasse 43, 8004 Zurich, Switzerland

Client **JWIT (Auden)**

CALIBRATION CERTIFICATE

Object(s) **ET3DV6 - SN:1753**

Calibration procedure(s) **QA CAL-01 v2**
Calibration procedure for dosimetric E-field probes

Calibration date: **August 26, 2004**

Condition of the calibrated item **In Tolerance (according to the specific calibration document)**

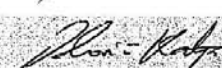
This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
 The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature 22 +/- 2 degrees Celsius and humidity < 75%.

Calibration Equipment used (M&TE critical for calibration)

Model Type	ID #	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Power meter EPM E4419B	GB41293874	5-May-04 (METAS, No 251-00388)	May-05
Power sensor E4412A	MY41495277	5-May-04 (METAS, No 251-00388)	May-05
Reference 20 dB Attenuator	SN: 5086 (20b)	3-May-04 (METAS, No 251-00389)	May-05
Fluke Process Calibrator Type 702	SN: 6295803	8-Sep-03 (Sintrel SCS No. E030020)	Sep-04
Power sensor HP 8481A	MY41092180	18-Sep-02 (SPEAG, in house check Oct03)	In house check: Oct 05
RF generator HP 8684C	US3642U01700	4-Aug-99 (SPEAG, in house check Aug02)	In house check: Aug05
Network Analyzer HP 8753E	US37390585	18-Oct-01 (SPEAG, in house check Oct03)	In house check: Oct 05

Calibrated by: **Nico Vetterli** **Function** **Technician** **Signature** 

Approved by: **Katja Pokovic** **Laboratory Director** 

Date issued: August 26, 2004

This calibration certificate is issued as an intermediate solution until the accreditation process (based on ISO/IEC 17025 International Standard) for Calibration Laboratory of Schmid & Partner Engineering AG is completed.

Probe ET3DV6

SN:1753

Manufactured:	April 15, 2003
Last calibrated:	May 23, 2003
Recalibrated:	August 26, 2004

Calibrated for DASY System s

(Note: non-compatible with DASY2 system!)

ET3DV6 SN:1753

August 26, 2004

DASY - Parameters of Probe: ET3DV6 SN:1753

Sensitivity in Free Space

Diode Compression^A

NormX	1.61 $\mu\text{V}/(\text{V}/\text{m})^2$
NormY	1.93 $\mu\text{V}/(\text{V}/\text{m})^2$
NormZ	1.99 $\mu\text{V}/(\text{V}/\text{m})^2$

DCP X	94	mV
DCP Y	94	mV
DCP Z	94	mV

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Please see Page 7.

Boundary Effect

Head 900 MHz Typical SAR gradient: 5 % per mm

Sensor Center to Phantom Surface Distance		3.7 mm	4.7 mm
SAR _{be} [%]	Without Correction Algorithm	8.6	4.5
SAR _{be} [%]	With Correction Algorithm	0.1	0.2

Head 1800 MHz Typical SAR gradient: 10 % per mm

Sensor Center to Phantom Surface Distance		3.7 mm	4.7 mm
SAR _{be} [%]	Without Correction Algorithm	12.5	8.6
SAR _{be} [%]	With Correction Algorithm	0.2	0.2

Sensor Offset

Probe Tip to Sensor Center	2.7 mm
Optical Surface Detection	in tolerance

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor $k=2$, which for a normal distribution corresponds to a coverage probability of approximately 95%.

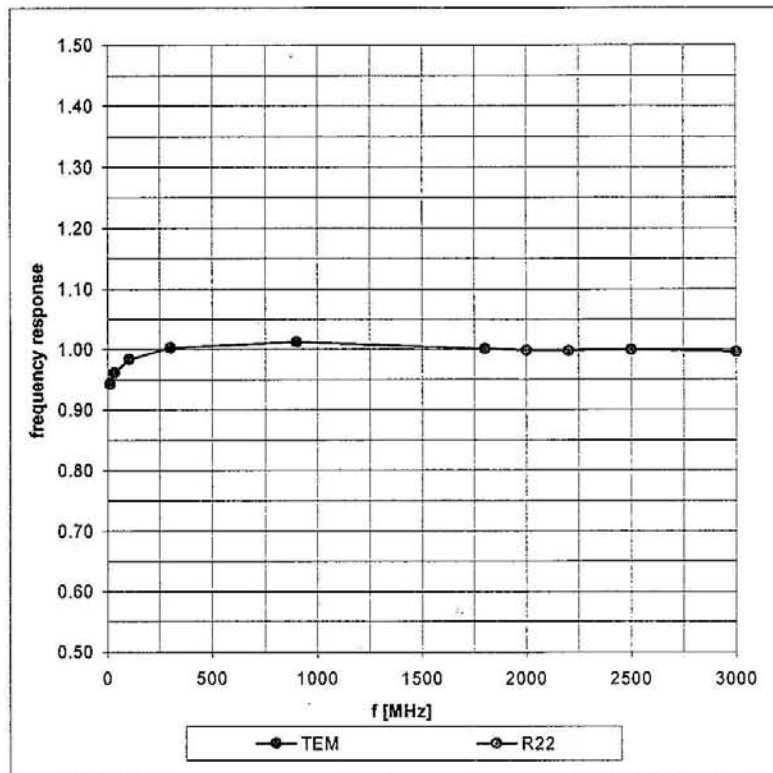
^A numerical linearization parameter; uncertainty not required

ET3DV6 SN:1753

August 26, 2004

Frequency Response of E-Field

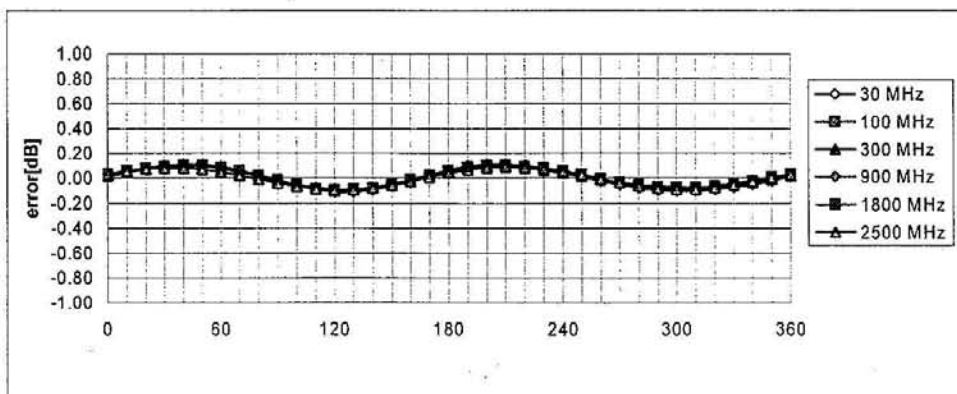
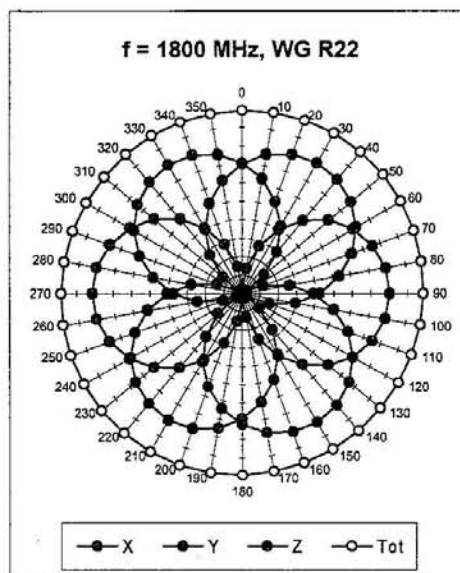
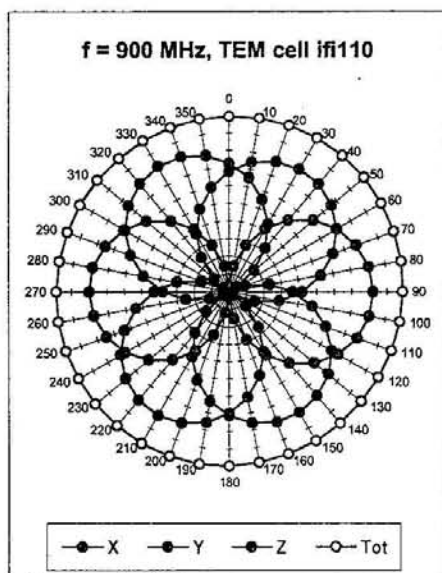
(TEM-Cell:ifi110, Waveguide R22)



ET3DV6 SN:1753

August 26, 2004

Receiving Pattern (ϕ), $\theta = 0^\circ$

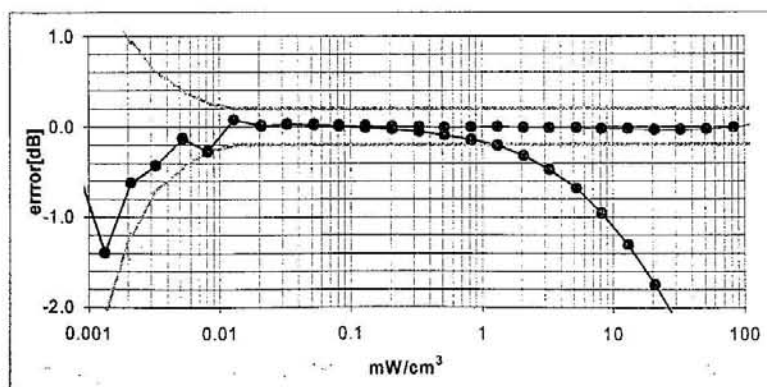
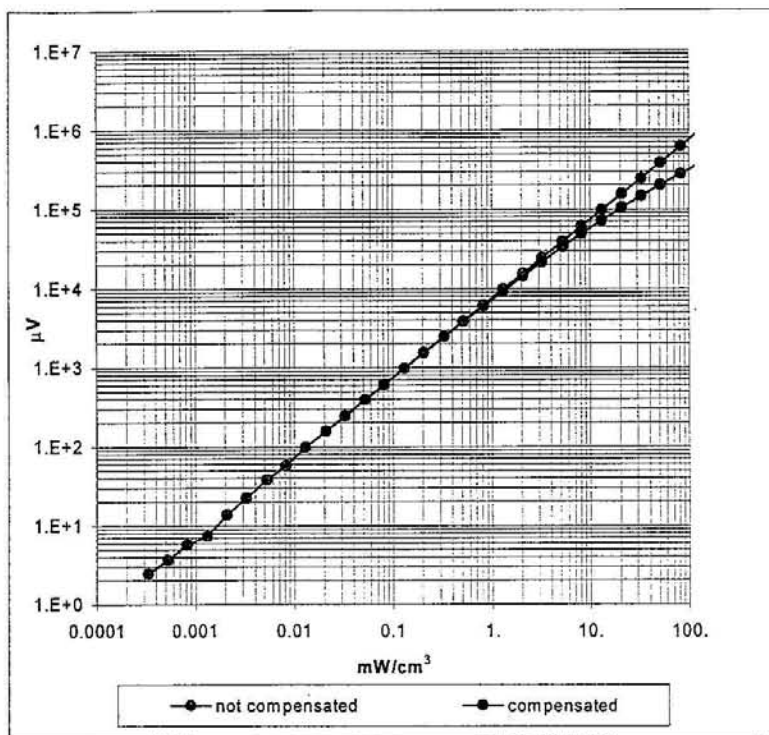


Axial Isotropy Error $< \pm 0.2$ dB

ET3DV6 SN:1753

August 26, 2004

Dynamic Range f(SAR_{head}) (Waveguide R22)

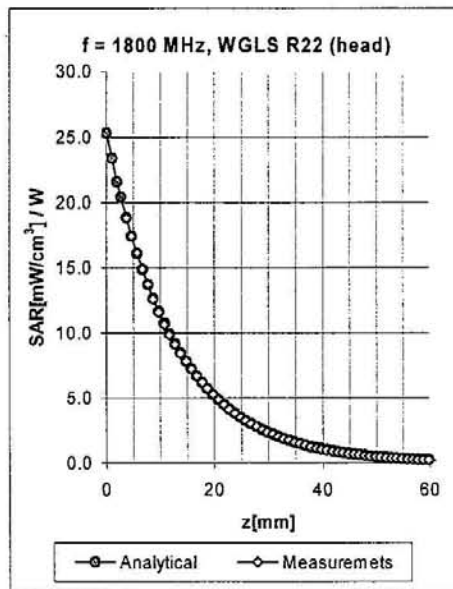
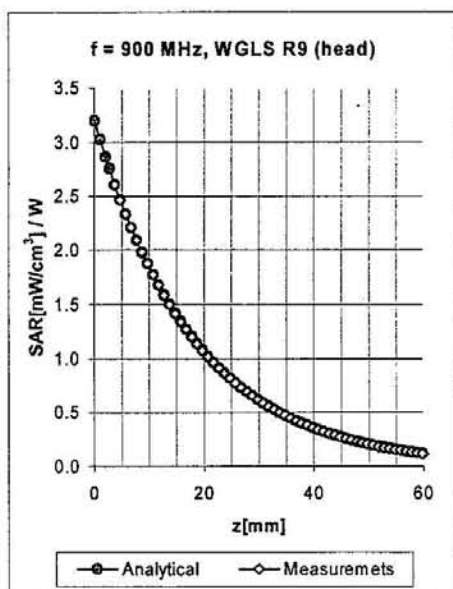


Probe Linearity Error $< \pm 0.2$ dB

ET3DV6 SN:1753

August 26, 2004

Conversion Factor Assessment



f [MHz]	Validity [MHz] ^B	Tissue	Permittivity	Conductivity	Alpha	Depth	ConvF Uncertainty
900	800-1000	Head	41.5 ± 5%	0.97 ± 5%	0.58	1.84	6.53 ± 11.3% (k=2)
1800	1710-1910	Head	40.0 ± 5%	1.40 ± 5%	0.46	2.65	5.17 ± 11.7% (k=2)
2450	2400-2500	Head	39.2 ± 5%	1.80 ± 5%	0.90	1.93	4.41 ± 9.7% (k=2)
900	800-1000	Body	55.0 ± 5%	1.05 ± 5%	0.51	2.08	6.02 ± 11.3% (k=2)
1800	1710-1910	Body	53.3 ± 5%	1.52 ± 5%	0.54	2.76	4.62 ± 11.7% (k=2)
2450	2400-2500	Body	52.7 ± 5%	1.95 ± 5%	1.21	1.54	4.25 ± 9.7% (k=2)

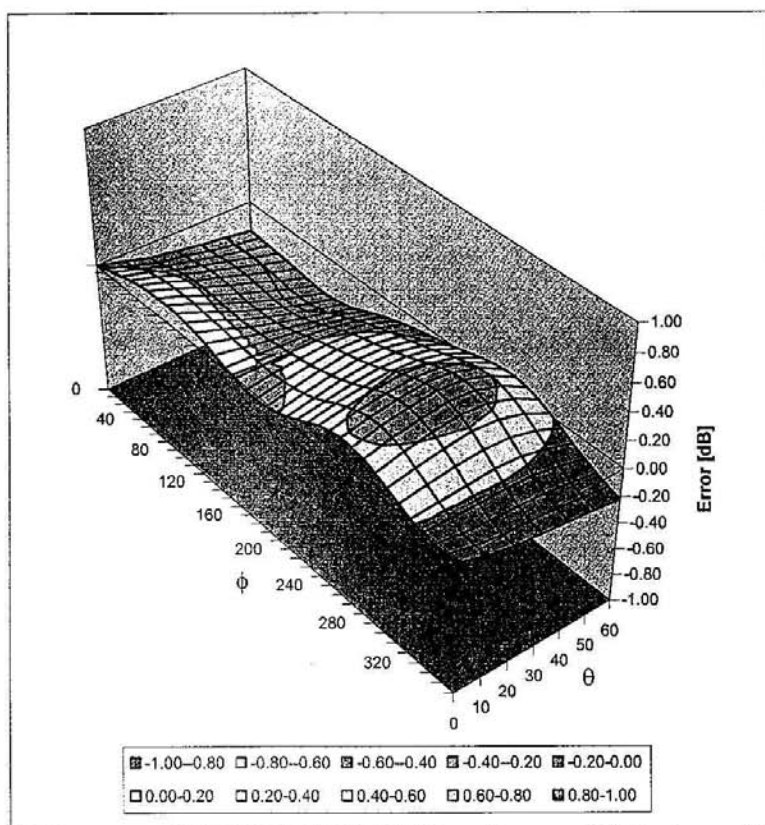
^B The total standard uncertainty is calculated as root-sum-square of standard uncertainty of the Conversion Factor at calibration frequency and the standard uncertainty for the indicated frequency band.

ET3DV6 SN:1753

August 26, 2004

Deviation from Isotropy in HSL

Error (θ, ϕ), $f = 900$ MHz



Spherical Isotropy Error $< \pm 0.4$ dB

D3: DAE SN: 579

Schmid & Partner Engineering AG

s p e a g

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info@speag.com, <http://www.speag.com>

IMPORTANT NOTICE

USAGE OF THE DAE 3

The DAE unit is a delicate, high precision instrument and requires careful treatment by the user. There are no serviceable parts inside the DAE. Special attention shall be given to the following points:

Battery Exchange: The battery cover of the DAE3 unit is connected to a fragile 3-pin battery connector. Customer is responsible to apply utmost caution not to bend or damage the connector when changing batteries.

Shipping of the DAE: Before shipping the DAE to SPEAG for calibration Customer shall remove the batteries and pack the DAE in an antistatic bag. The packaging shall protect the DAE from impacts during transportation. The package shall be marked to indicate that a fragile instrument is inside.

E-Stop Failures: Touch detection may be malfunctioning due to broken magnets in the E-stop. Rough handling of the E-stop may lead to damage of these magnets. Touch and collision errors are often caused by dust and dirt accumulated in the E-stop. To prevent E-stop failure, Customer shall always mount the probe to the DAE carefully and keep the DAE unit in a non-dusty environment if not used for measurements.

Repair: Minor repairs are performed at no extra cost during the annual calibration. However, SPEAG reserves the right to charge for any repair especially if rough unprofessional handling caused the defect.

Important Note:

Warranty and calibration is void if the DAE unit is disassembled partly or fully by the Customer.

Important Note:

Never attempt to grease or oil the E-stop assembly. Cleaning and readjusting of the E-stop assembly is allowed by certified SPEAG personnel only and is part of the annual calibration procedure.

Schmid & Partner Engineering

Calibration Laboratory of
Schmid & Partner
Engineering AG
 Zeughausstrasse 43, 8004 Zurich, Switzerland



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Accreditation No.: **SCS 108**

Client **ADT (Auden)**

Certificate No: **DAE3-579_Mar05**

CALIBRATION CERTIFICATE

Object **DAE3 - SD 000 D03 AA - SN: 579**

Calibration procedure(s) **QA CAL-06.v10**
Calibration procedure for the data acquisition unit (DAE)

Calibration date: **March 23, 2005**

Condition of the calibrated item **In Tolerance**

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 The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Fluke Process Calibrator Type 702	SN: 6295803	7-Sep-04 (Sintrel, No.E-040073)	Sep-05
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Calibrator Box V1.1	SE UMS 006 AB 1002	16-Jul-04 (SPEAG, in house check)	In house check Jul-05

Calibrated by:	Name Eric Hainfeld	Function Technician	Signature 
Approved by:	Fin Bomholt	R&D Director	

Issued: March 23, 2005

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

**Calibration Laboratory of
Schmid & Partner
Engineering AG**
Zeughausstrasse 43, 8004 Zurich, Switzerland



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Glossary

DAE digital acquisition electronics
Connector angle information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- **DC Voltage Measurement:** Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- **Connector angle:** The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters contain technical information as a result from the performance test and require no uncertainty.
- **DC Voltage Measurement Linearity:** Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
- **Common mode sensitivity:** Influence of a positive or negative common mode voltage on the differential measurement.
- **Channel separation:** Influence of a voltage on the neighbor channels not subject to an input voltage.
- **AD Converter Values with inputs shorted:** Values on the internal AD converter corresponding to zero input voltage
- **Input Offset Measurement:** Output voltage and statistical results over a large number of zero voltage measurements.
- **Input Offset Current:** Typical value for information; Maximum channel input offset current, not considering the input resistance.
- **Input resistance:** DAE input resistance at the connector, during internal auto-zeroing and during measurement.
- **Low Battery Alarm Voltage:** Typical value for information. Below this voltage, a battery alarm signal is generated.
- **Power consumption:** Typical value for information. Supply currents in various operating modes.

DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V , full range = -100...+300 mV

Low Range: 1LSB = 61nV , full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.498 $\pm$ 0.1% (k=2)	404.560 $\pm$ 0.1% (k=2)	404.343 $\pm$ 0.1% (k=2)
Low Range	3.95298 $\pm$ 0.7% (k=2)	3.97918 $\pm$ 0.7% (k=2)	3.94012 $\pm$ 0.7% (k=2)

Connector Angle

Connector Angle to be used in DASY system	310 $^{\circ}$ $\pm$ 1 $^{\circ}$
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Appendix

1. DC Voltage Linearity

High Range	Input (μV)	Reading (μV)	Error (%)
Channel X + Input	200000	200000	0.00
Channel X + Input	20000	20000.39	0.00
Channel X - Input	20000	-19991.88	-0.04
Channel Y + Input	200000	200000.2	0.00
Channel Y + Input	20000	19997.23	-0.01
Channel Y - Input	20000	-19994.34	-0.03
Channel Z + Input	200000	199999.8	0.00
Channel Z + Input	20000	19996.66	-0.02
Channel Z - Input	20000	-19995.76	-0.02

Low Range	Input (μV)	Reading (μV)	Error (%)
Channel X + Input	2000	2000.1	0.00
Channel X + Input	200	199.65	-0.18
Channel X - Input	200	-200.44	0.22
Channel Y + Input	2000	1999.9	0.00
Channel Y + Input	200	199.72	-0.14
Channel Y - Input	200	-200.84	0.42
Channel Z + Input	2000	2000	0.00
Channel Z + Input	200	199.53	-0.24
Channel Z - Input	200	-201.02	0.51

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	6.17	5.48
	- 200	-5.20	-5.89
Channel Y	200	8.93	9.11
	- 200	-9.89	-10.38
Channel Z	200	9.08	8.94
	- 200	-10.25	-10.98

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	0.60	-0.26
Channel Y	200	1.53	-	2.09
Channel Z	200	-2.89	0.01	-

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	16329	16485
Channel Y	16181	15912
Channel Z	15805	16242

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M Ω

	Average (μ V)	min. Offset (μ V)	max. Offset (μ V)	Std. Deviation (μ V)
Channel X	0.26	-0.64	1.42	0.47
Channel Y	-1.12	-2.09	0.11	0.36
Channel Z	-0.86	-1.58	0.11	0.31

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance

	Zeroing (MOhm)	Measuring (MOhm)
Channel X	0.2000	200.3
Channel Y	0.2000	203.3
Channel Z	0.2000	204.4

8. Low Battery Alarm Voltage (verified during pre test)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (verified during pre test)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.0	+6	+14
Supply (- Vcc)	-0.01	-8	-9

10. Common Mode Bit Generation (verified during pre test)

Typical values	Bit set to High at Common Mode Error (V _{DC})
Channel X, Y, Z	+1.25



APPENDIX D: SYSTEM CERTIFICATE & CALIBRATION

D1: SAM PHANTOM

Schmid & Partner Engineering AG

Zeughausstrasse 43, 8004 Zurich, Switzerland, Phone +41 1 245 97 00, Fax +41 1 245 97 79

Certificate of conformity / First Article Inspection

Item	SAM Twin Phantom V4.0
Type No	QD 000 P40 CA
Series No	TP-1150 and higher
Manufacturer / Origin	Untersee Composites Hauptstr. 69 CH-8559 Fruthwilen Switzerland

Tests

The series production process used allows the limitation to test of first articles. Complete tests were made on the pre-series Type No. QD 000 P40 AA, Serial No. TP-1001 and on the series first article Type No. QD 000 P40 BA, Serial No. TP-1006. Certain parameters have been retested using further series units (called samples).

Test	Requirement	Details	Units tested
Shape	Compliance with the geometry according to the CAD model.	IT'IS CAD File (*)	First article, Samples
Material thickness	Compliant with the requirements according to the standards	2mm +/- 0.2mm in specific areas	First article, Samples
Material parameters	Dielectric parameters for required frequencies	200 MHz – 3 GHz Relative permittivity < 5 Loss tangent < 0.05.	Material sample TP 104-5
Material resistivity	The material has been tested to be compatible with the liquids defined in the standards	Liquid type HSL 1800 and others according to the standard.	Pre-series, First article

Standards

- [1] CENELEC EN 50361
- [2] IEEE P1528-200x draft 6.5
- [3] IEC PT 62209 draft 0.9

(*) The IT'IS CAD file is derived from [2] and is also within the tolerance requirements of the shapes of [1] and [3].

Conformity

Based on the sample tests above, we certify that this item is in compliance with the uncertainty requirements of SAR measurements specified in standard [1] and draft standards [2] and [3].

Date 28.02.2002

Signature / Stamp

F. Bombault

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Thomas Kappeler